

Certificate of Analysis

MBH-83X PR4 J

Lead with Impurities (Cast)

Certified Reference Material

Certified Values listed in wt.% with associated uncertainties

Ag	0.0104 ± 0.0008	Au	0.0021 ± 0.0005	Bi	0.0131 ± 0.0007	Cd	0.0073 ± 0.0002
Cu	0.038 ± 0.002	In	0.0015 ± 0.0006	Ni	0.0018 ± 0.0001	Sb	0.0040 ± 0.0007
Se	0.0024 ± 0.0006	Te	0.020 ± 0.004	Tl	0.0022 ± 0.0006		

Indicative Values listed in ppm

Hg (200)

Description and Intended Use

This **Certified Reference Material** is covered under the scope of accreditation to **ISO 17034** by LGC Standards - Manchester, NH. As an ISO 17034 certified reference material, appropriate use of this material will fulfill the certified reference material and traceability requirements for use in **ISO 17025** certified laboratories. This CRM may come in the form of a solid disk or chips. The intended use of this CRM may include, but is not limited to, the calibration of instruments and the validation of analytical methods.

Instructions for Use

1. The test surface is on the opposite side of the labeled surface, which includes the material identification. The entire thickness of the unit is certified. However, the user is cautioned not to measure disks less than 2 mm thick when using X-ray fluorescence spectrometry. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing, as these processes may contaminate the surface.
2. The minimum sample size for chips should be individually evaluated based on the analytical technique used; this would typically be greater than 0.1 grams.
3. The material should be stored in a cool, dry location when not in use.
4. Chips are not recommended for gas analysis.

The following data represents all pertinent information reported as it applies to the chemical characterization of this material.

	Ag	Au	Bi	Cd	Cu	Hg	In	Ni	Sb	Se	Te	Tl				
1	0.0088	0.0015	0.0117	0.0070	0.0335	0.0145	0.0009	0.0016	0.0031	0.0017	0.0164	0.0011				
2	0.0098	0.0018	0.0127	0.0070	0.0353	0.0170	0.0010	0.0017	0.0032	0.0017	0.0180	0.0020				
3	0.0098	0.0020	0.0127	0.0071	0.0357	0.0194	0.0010	0.0017	0.0037	0.0018	0.0188	0.0021				
4	0.0099	0.0021	0.0131	0.0072	0.0370	0.0397	0.0013	0.0018	0.0040	0.0021	0.0195	0.0023				
5	0.0104	0.0026	0.0132	0.0073	0.0374		0.0016	0.0019	0.0043	0.0022	0.0226	0.0026				
6	0.0108	0.0028	0.0134	0.0074	0.0383		0.0020	0.0020	0.0048	0.0027	0.0259	0.0029				
7	0.0111		0.0135	0.0075	0.0384		0.0028	0.0020	0.0051	0.0035						
8	0.0112		0.0147	0.0076	0.0390			0.0020		0.0036						
9	0.0122			0.0079	0.0413											
10					0.0418											
11																
12																
13																
14																
15																
Mean	0.0104	0.0021	0.0131	0.0073	0.0378	0.0227	0.0015	0.0018	0.0040	0.0024	0.0202	0.0022				
STDV.	0.0010	0.0005	0.0009	0.0003	0.0026	0.0115	0.0007	0.0002	0.0008	0.0008	0.0035	0.0006				
Certified	0.0104	0.0021	0.0131	0.0073	0.038	(0.02)	0.0015	0.0018	0.0040	0.0024	0.020	0.0022				
U _{CRM}	0.0008	0.0005	0.0007	0.0002	0.002		0.0006	0.0001	0.0007	0.0006	0.004	0.0006				
Methods	A,I,W	A,I	A,I,W	A,I	A,I,W	I	A,I	A,I	A,I	A,I	A,I	I				

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES

Certification Laboratories

Universal Scientific Laboratory PTY LTD
Sheffield Analytical Services
Mineral & Metallurgical Laboratories
Tec-Eurolab
AMG Superalloys UK Ltd.

NSW, Australia
Sheffield, UK
Bangalore, India
Campogalliano, Italy
Rotherham, England

Siec Badawcza Lukaszewicz
Anchorcert Analytical
I.M.N.R.
Genitest Inc.

Poland
Birmingham, England
Pantelimon, Romania
Montreal, QC

Much of the analytical work performed to assess this material has been carried out by laboratories with proven competence, as indicated by their accreditation to ISO 17025. It is an implicit requirement for this accreditation that analytical work should be performed with due traceability, via an unbroken chain of comparisons, each with stated uncertainty, to primary standards such as the mole, or to nationally- or internationally-recognised reference materials. Of the individual results herein, some have traceability (to the mole) via primary analytical methods. Some are traceable to substances of known stoichiometry. Most have traceability via commercial solutions. Furthermore, some results have additional traceability to NIST standards, as part of the analytical calibration or process control.

Homogeneity and Uncertainty

"Uncertainty" values, as reported adjacent to certified concentration values, are based on a 95% Confidence Interval. These estimated uncertainties include the combined effects of method imprecision, material inhomogeneity, and any bias between methods. Homogeneity data from experimental spark OES results are reflected in both the overall statistics and certified data. Homogeneity samples are selected by a systematic sampling procedure. The number of samples may be determined by equation 1, where N_{prod} is the number of units produced and N_{min} is the number of samples used for homogeneity testing. These samples are arranged in a simple randomized design such that each sample is analyzed multiple times by spark OES. Homogeneity may also be determined within sample using an applied version of ASTM E826. A single factor ANOVA is used to calculate uncertainty due to inhomogeneity (U_{hom}). Uncertainty of the material is calculated by equation 2, where H=U_{hom}, S= Standard deviation, t= t-value at 95% CI, and n= number of observations.

$$1. N_{min} = \max(10, \sqrt[3]{N_{prod}})$$

$$2. U_{CRM} = \frac{\sqrt{H^2 + S^2}}{\sqrt{n}} * t$$

Expiration

The certification of this material is valid indefinitely, within the uncertainty specified, provided the material is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the material is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.


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ARMI | MBH - LGC Standards Industrial Sector

